



**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$		-	1.3	$^{\circ}C/W$
Thermal resistance, junction-ambient <sup>②</sup>	$R_{thJA}$		-	45	$^{\circ}C/W$
Soldering temperature(total time<10s)	$T_{sold}$		-	260	$^{\circ}C$

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-60			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\mu A$	-1.3	-1.8	-2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS} = 0V, V_{DS} = -60V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -16A$		12	17	m $\Omega$
		$V_{GS} = -4.5V, I_D = -12A$		16	23	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = -5V, I_{SD} = -10A$		25		S
Diode Forward Voltage	$V_{FSD}$	$V_{GS} = 0V, I_{SD} = -16A$			1.3	V

**•Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	$C_{iss}$	$f = 1MHz, V_{DS} = -25V$	-	7300	-	pF
Output capacitance	$C_{oss}$		-	355	-	
Reverse transfer capacitance	$C_{rss}$		-	272	-	
Gate Resistance	$R_g$	$f = 1MHz$	-	4		$\Omega$
Total gate charge	$Q_g$	$V_{DD} = -15V, I_D = -20A, V_{GS} = -10V$	-	103	-	nC
	$Q_g(-4.5v)$		-	41	-	
Gate - Source charge	$Q_{gs}$		-	14	-	
Gate - Drain charge	$Q_{gd}$		-	15	-	
Turn-ON Delay time	$t_{D(on)}$		-	22	-	
Turn-ON Rise time	$t_r$	$V_{GS} = -10V, V_{DS} = -15V,$	-	35	-	ns
Turn-Off Delay time	$t_{D(off)}$	$R_G = 3.3\Omega, I_D = -20A$	-	285	-	ns
Turn-Off Fall time	$t_f$		-	78	-	ns
Reverse Recovery Time	$t_{RR}$	$V_{DD} = -20V, di_S/dt =$	-	74	-	ns
Reverse Recovery Charge	$Q_{RR}$	$100A/\mu s, I_S = -20A$	-	287	-	nC

Fig.1 Gate-Charge Characteristics

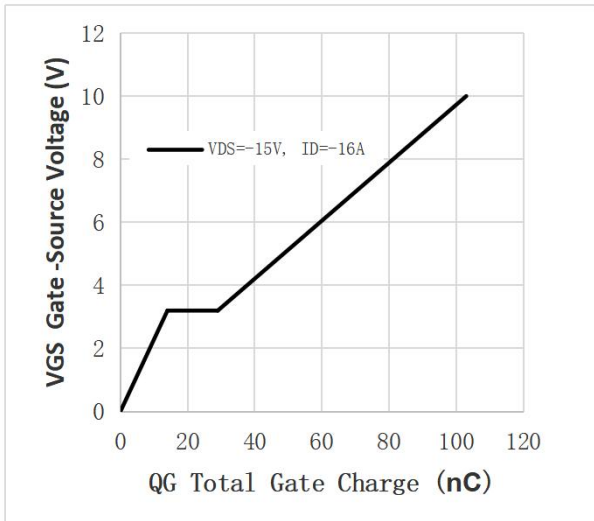


Fig.2 Capacitance Characteristics

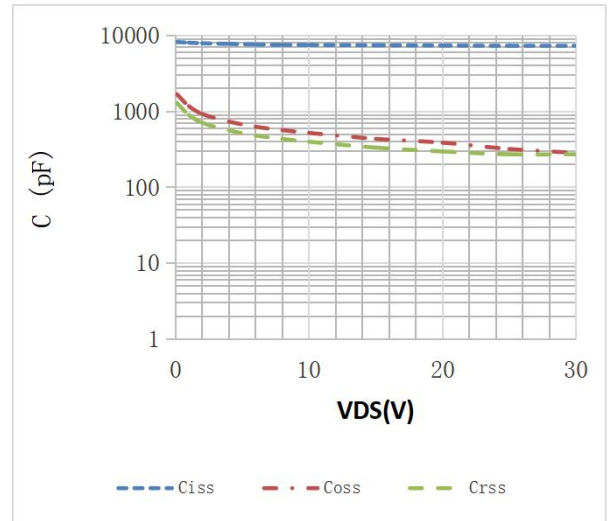


Fig.3 Power Dissipation

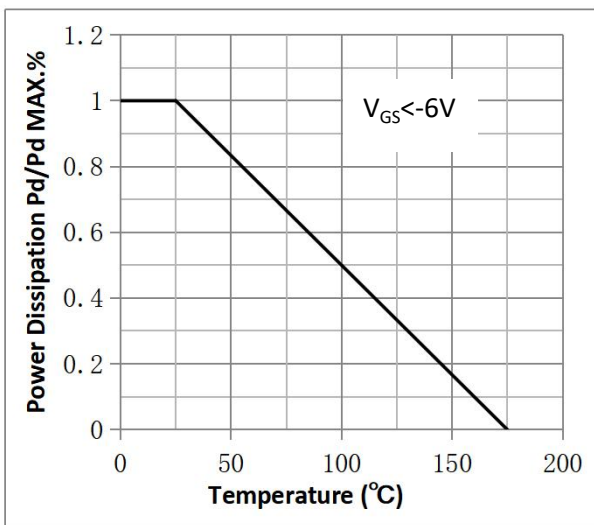


Fig.4 Typical output Characteristics

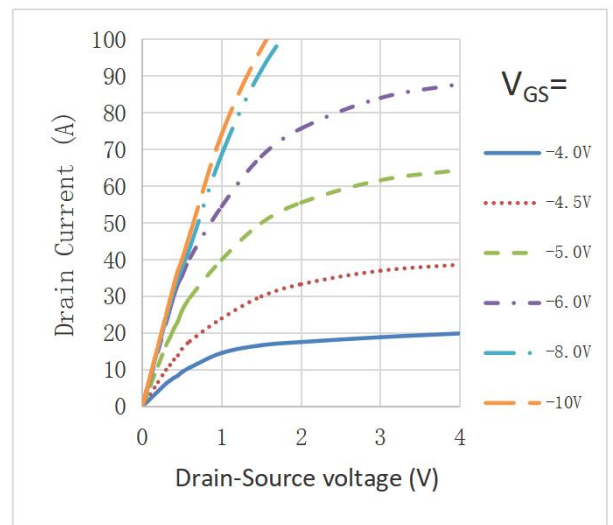


Fig.5 Threshold Voltage V.S Junction Temperature

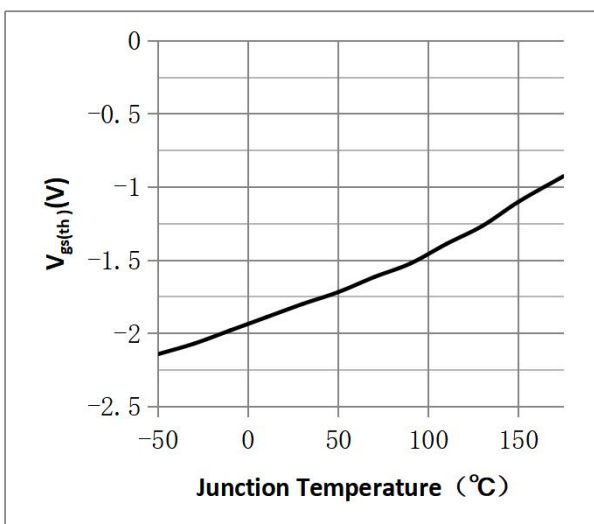


Fig.6 Resistance V.S Drain Current

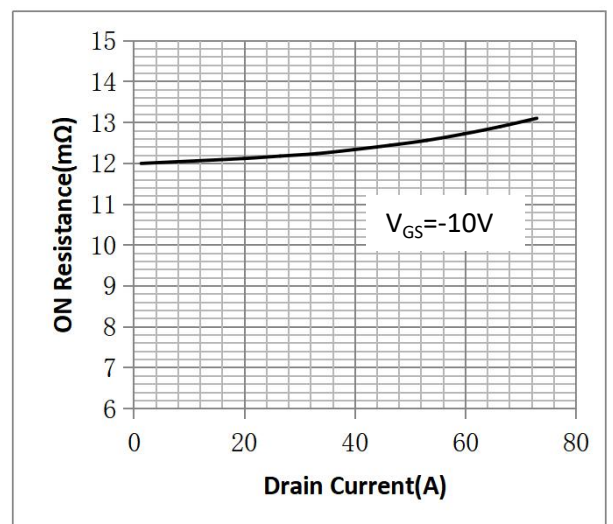


Fig.7 On-Resistance VS Gate Source Voltage

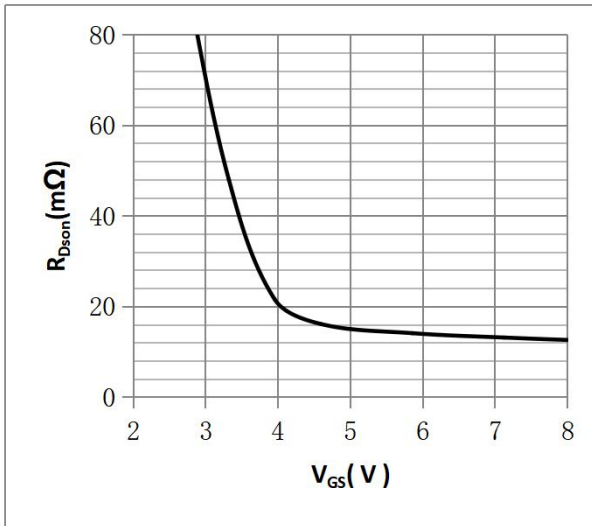


Fig.8 On-Resistance V.S Junction Temperature

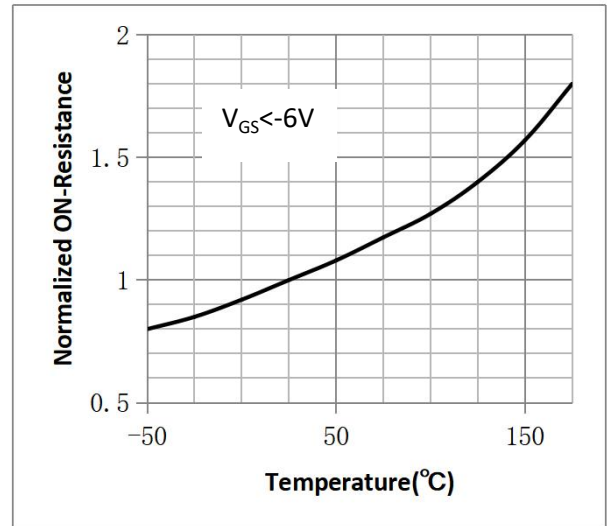


Figure 9. Diode Forward Voltage vs. Current

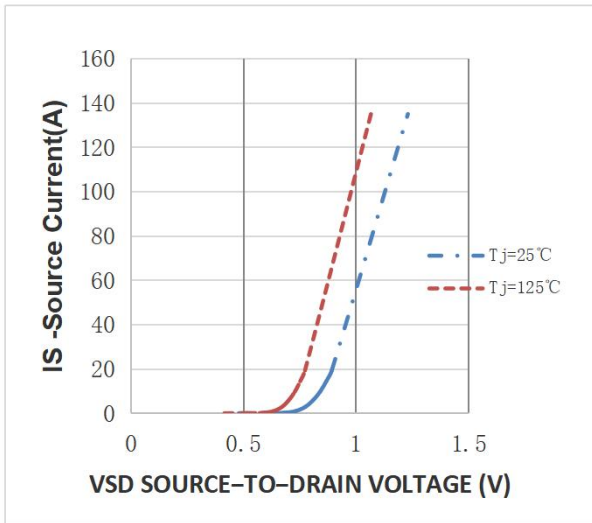


Figure 10. Transfer Characteristics

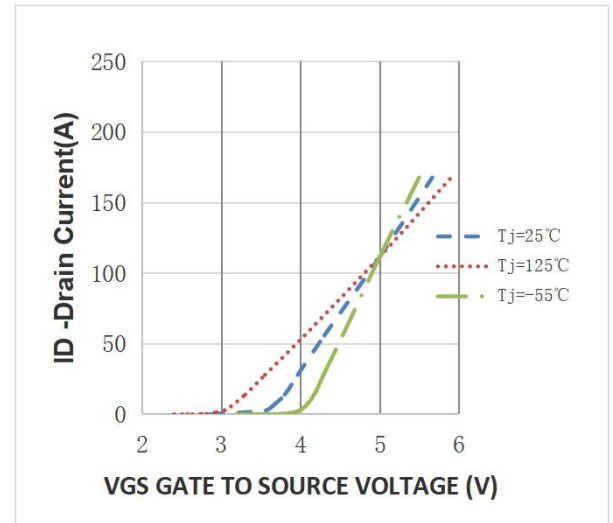


Fig.11 Safe Operating Area

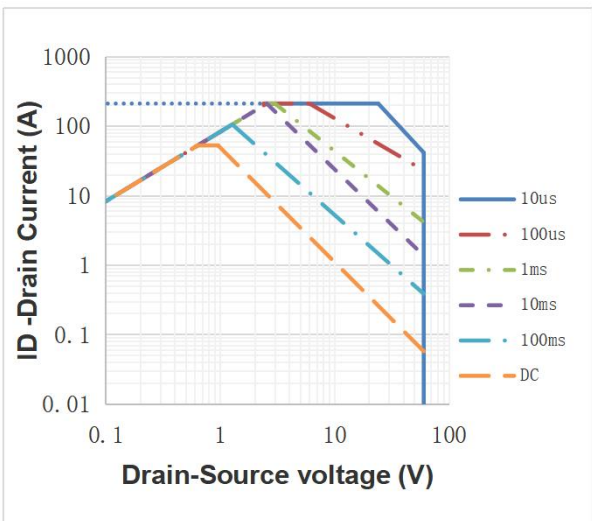
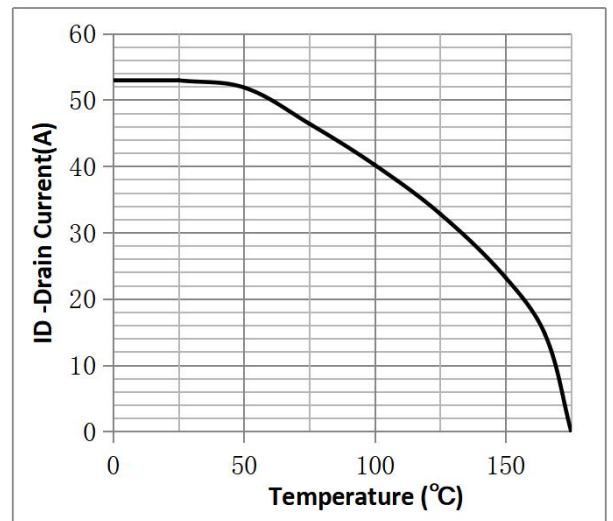
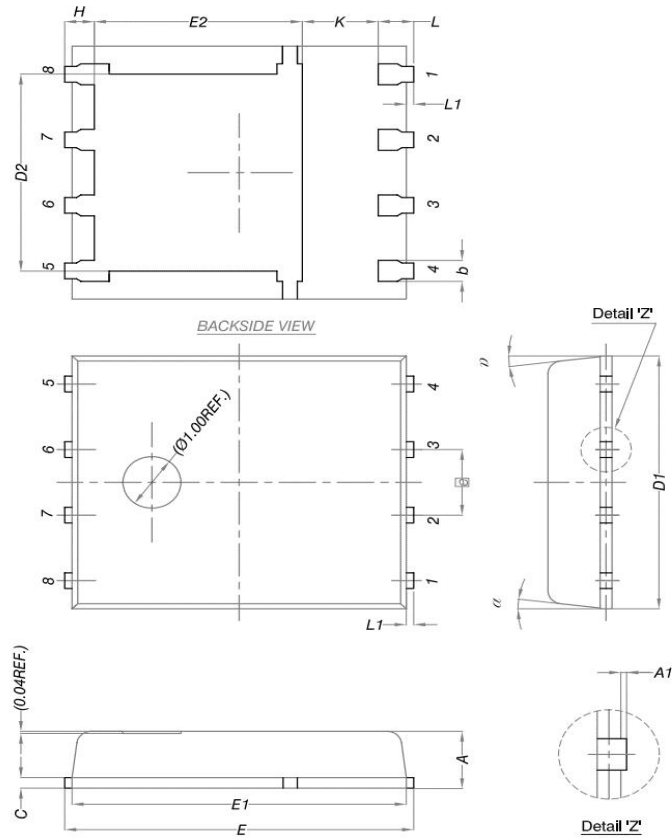


Fig.12 ID vs. Case Temperature<sup>③</sup>



•DFN5\*6 Package Outline



DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.33	0.41	0.51
C	0.20	0.25	0.30
D1	4.80	4.90	5.00
D2	3.61	3.81	3.96
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
$\alpha$	0°	-	12°

**Note:**

- ① Pulse :  $V_{GS}=+20V/-20V$ , Duty cycle=50%,  $T_j=175^{\circ}C$ ,  $t=1000$  hours; For DC , the following test conditions can be passed:  $V_{GS}=-20V/+10V$ ,  $T_j=175^{\circ}C$ ,  $t=1000$  hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature.  $V_{GS}=-10V$ .

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## Revision History

Version	Date	Change
A	2021.2.3	
B	2022.9.7	1.Add Reach, HF figure, 2.ID modify
C	2023.12.13	Add Qrr、Trr